

EMC TEST REPORT

Project No.	LBE20142450	Issue No.	0
Applicant	Name of organization	Samsung Electronics Co., Ltd.	
	Address	(Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 443-742, Republic of Korea	
	Date of application	April 17, 2014	
EUT	Type of device	☒ Class B personal computers and peripherals ☐ All other devices	
	Equipment authorization	☐ Declaration of Conformity ☒ Certification ☐ Verification	
	FCC ID	A3LSMT705	
	Kind of product	Portable Device	
	Model No.	SM-T705	
	Variant Model No.	Refer to clause 4.6	
	Manufacturer	SAMSUNG ELECTRONICS CO., LTD. 94-1, Imsu-dong, Gumi-si, Gyengsangbuk-do, 730-722, Republic of Korea SAMSUNG ELECTRONICS HUIZHOU CO.,LTD. 516229, Chenjiang Town, HuiZhou City, Guangdong Province, China	
Applied Standards		FCC Part 15, Subpart B, Class B / ANSI C63.4-2009	
Test Period		April 19, 2014 ~ April 23, 2014	
Issue date		April 23, 2014	

Test result : Complied

The equipment under test has found to be compliant with the applied standards.
 (Refer to the attached test result for more detail.)

Tested by : Jong-Sup Jeong



Reviewed by : Tae-Young Jang



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1. Report Information

1.1 Revision history

No.	Revised detailed information
Issue 0	- LBE20142450 (SAMSUNG)

2. Summary of test results

1.1 Emission

The EUT has been tested according to the following specifications:

Applied	Test type	Applied standard	Result
☒	Conducted Disturbance (Mains port)	FCC Part 15 Subpart B / ANSI C63.4-2009 (Class B)	Complied
☒	Radiated Disturbance		Complied

3. General Information

3.1 Test facility

The CS & Environment center is located on Samsung Electronics Co., Ltd. at (Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Republic of Korea.

All testing are performed in Semi-anechoic chambers conforming to the site attenuation characteristics defined by ANSI C63.4, CISPR 22, 16-1 and 16-2. and Shielded rooms.

The CS & Environment center is operated as testing laboratory in accordance with the requirements of ISO/IEC 17025:2005.

4. Test Setup configuration

4.1 Test Peripherals

The cables used for these peripherals are either permanently attached by the peripheral manufacturer or coupled with an assigned cable as defined below.

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Mark	Description	Model No.	Serial No.	Manufacturer / Trademark	FCC ID / DoC
A	Portable Device	SM-T705	-	SAMSUNG	A3LSMT705
B	Battery	EB-BT705FBE	AAbF325tS/7-B	SAMSUNG	-
C	Headset	EO-HS3303WE	-	SAMSUNG	-
D	Data Cable	ECB-DU4AWE	-	SAMSUNG	-
E	HDTV Adapter	ET-H10FAUWE	RT1D913AS E	SAMSUNG	-
F	Ferrite Core	ZCAT1325-0530	-	TDK	-
G	microSD Card	32GB	-	SANDISK	-
H	Travel Adapter	EP-TA10EWE	SE1D621AS/C-E	SAMSUNG	-
I	Desk-Top Computer	DM300S3A	-	SAMSUNG	DoC
			EBDEDC6FFD	SAMSUNG	DoC
J	LCD TV Monitor	UN22ES5003	ZV8R33ECC00129J	SAMSUNG	DoC
		CF19MS	CF19H1LS700048Y	SAMSUNG	DoC
		EF23TS	NC26H1KSB01550B	SAMSUNG	DoC
K	Mouse	SML-210PB	TAKD125024 V	SAMSUNG	DoC
			TAKD124911 M	SAMSUNG	DoC
L	Keyboard	SDM8500P	8M001183	SAMSUNG	DoC
			8M001033	SAMSUNG	DoC
M	Gigabit Switch 8	J9794A	CN33FQ703Q	HP	DoC
			CN33FQ71XK	HP	DoC
N	Power Supply	EADP-15DC A	DIKD1245096741	Delta	DoC
			DIKD1245096576	Delta	DoC

This tablet device does not contain the minimum number of ports required for personal computer testing per ANSI C63.4, but the EUT is attached to a computer through its only available port, which represents worst case emissions. All other aspects of C63.4 testing requirements were maintained.

4.2 EUT operating mode

To achieve compliance applied standard specification, the following mode(s) were made during compliance testing:

Operating Mode 1	USB Mode (Data Communication)
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4.3 Details of Sampling

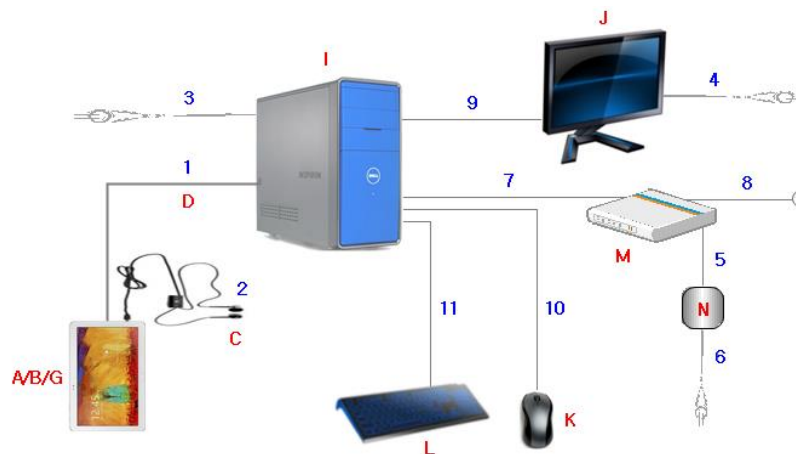
Customer selected, single unit.

4.4 Used cable description

The EUT is configured, installed, arranged and operated in a manner consistent with typical applications. Interface cables/loads/devices are connected to at least one of each type of interface port of the EUT, and where practical, each cable shall be terminated in a device typical of actual usage. The type(s) of interconnecting cables to be used and the interface port (of the EUT) to which these were connected:

No.	Connected cable	Length [m]	Shielded [Y/N]	Note
1	Data Cable, Travel Adapter	1.0	Yes	From EUT to Desk-Top Computer, From EUT to Travel Adapter
2	Headset	1.2	No	For EUT
3	Power	1.8	No	For Desk-Top Computer
4	Power	1.8	No	For LCD TV Monitor
5	Power	1.8	No	From Gigabit Switch 8 to Power Supply
6	Power	1.8	No	For Power Supply
7	LAN	1.5	No	From Desk-Top Computer to Gigabit Switch 8
8	LAN	1.5	No	From Gigabit Switch 8 to Local Area Network
9	RGB	1.8	Yes	From Desk-Top Computer to LCD TV Monitor
10	PS/2	1.8	Yes	From Desk-Top Computer to Mouse
11	PS/2	1.8	Yes	From Desk-Top Computer to Keyboard
12	MHL	0.1	Yes	From EUT to HDMI Cable
13	HDMI	1.1	Yes	From HDTV Adapter to LCD TV Monitor

4.5 Test arrangement



4.6 EUT Description

4.6.1 The following features describe EUT represented by this report:

Item	Specification	
Frequency Range	GSM850	TX : 824.2 ~ 848.8 MHz RX : 869.2 ~ 893.8 MHz
	GSM1900	TX : 1 850.2 ~ 1 909.8 MHz RX : 1 930.2 ~ 1 989.8 MHz
	WCDMA FDD2	TX : 1 852.4 ~ 1 907.6 MHz RX : 1 932.4 ~ 1 987.6 MHz
	WCDMA FDD5	TX : 826.4 ~ 846.6 MHz RX : 871.4 ~ 891.6 MHz
	LTE FDD5	TX : 824 ~ 849 MHz RX : 869 ~ 894 MHz
Operating Temperature (°C)	+5 ~ +35	
Operating Humidity (%)	0 ~ 95	

4.6.2 The variant models

- None

4.7 Clock Frequencies

Kind of Clocks	Frequency [MHz]	Kind of Clocks	Frequency [MHz]
CPU	1 900	USB 2.0	24
MHL	74.25		

4.8 Test configuration and condition

- ☐ The EUT exercise program which is the samsung standardized emission test program for windows was used during all EMC measurements were tested. This program was contained on the PC hard disk drive. Once loaded, the program sequentially exercises each system component in turn.
- ☒ The EUT was exercised during the testing by data read and write cycles repeated with internal storage devices. At the end of the test, the copied back data was compared with original.
- ☐ The EUT was connected to the PC by using USB data cable to charge.
- ☐ The system was configured for testing in a typical fashion that a customer would normally use, and was tested while in an automated non-attendant mode.

Power source for the EUT operating was supplied by CVCF made by the Pacific Power Source Corp.

- Test Voltage : AC 120 V, 60 Hz

4.9 Measurement uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus: (According to CISPR 16-4 and UKAS Lab 34.)

4.9.1 Emission

Test type		Measurement uncertainty (C.L. 95 %, k = 2)
Conducted disturbance	AC Mains	3.12 dB
Radiated Disturbance (30 MHz ~ 1 GHz)	Horizontal	4.03 dB
	Vertical	4.13 dB
Radiated Disturbance (1 GHz ~ 6 GHz)	Horizontal	4.53 dB
	Vertical	4.51 dB

5. Results of individual test

5.1 Conducted disturbance

The EUT was connected to the Desk-Top Computer which was powered from one LISN for the measurements. The support equipment power cables were connected to a second LISN.

Both conducted lines are measured in Quasi-Peak and Average mode, including the worst-case data points for each tested configuration. The EUT measured in accordance with the methods described in standards.

Limits for conducted disturbance at the mains ports of Class B ITE

Frequency range Limits [MHz]	Resolution Bandwidth [kHz]	Limits [dB(μV)]	
		Quasi-peak	Average
0,15 to 0,50	9	66 to 56	56 to 46
0,50 to 5	9	56	46
5 to 30	9	60	50

NOTE 1 The lower limit shall apply at the transition frequency.
NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

5.1.1 Test instrumentation

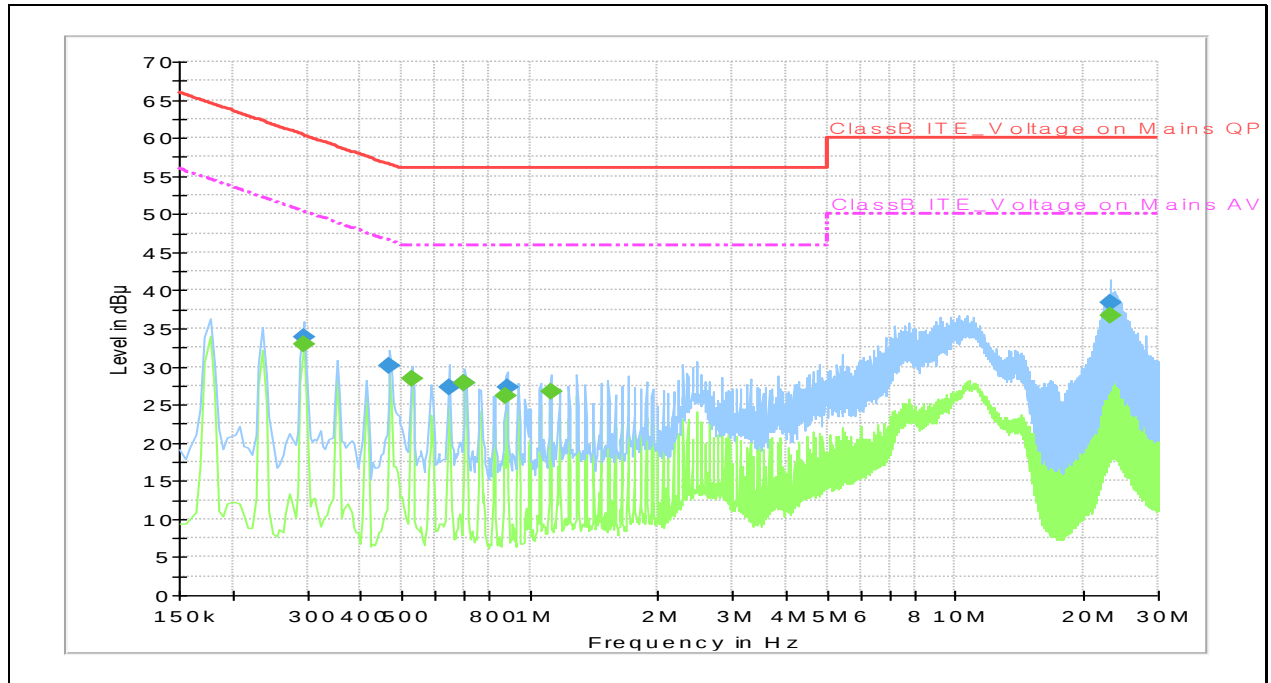
EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-010	LISN	ESH3-Z5	R&S	100263	2013-10-17	12
E5I-016	EMI Test Receiver	ESU8	R&S	100482	2013-06-11	12
E5I-043	LISN	ENV216	R&S	101630	2013-06-07	12

5.1.2 Temperature and humidity condition

Test date	2014-04-23	Test engineer	Jong-Sup Jeong
Climate condition	Ambient temperature	23.8 °C	Limit (15.0 to 35.0) °C
	Relative humidity	39.0 % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	101.3 kPa	Limit (86.0 to 106.0) kPa
Test place	Shield Room (SR14)		

5.1.3 Test results

□ Operating Mode 1: AC Mains



Note 1) Two graphs measured for both Live(L1) and Neutral(N) of the LISN are combined into one graph.

Final measurement results table(QP):

Frequency (MHz)	Level (dBμV)	Corr. (dB)	Limit (dBμV)	Margin (dB)	Line
0.294	33.9	9.9	60.4	26.5	L1
0.470	30.1	9.9	56.5	26.4	L1
0.645	27.3	9.9	56	28.7	L1
0.704	27.8	9.8	56	28.2	L1
0.884	27.3	9.8	56	28.7	L1
23.262	38.5	9.9	60	21.5	N

Final measurement results table(CAV):

Frequency (MHz)	Level (dBμV)	Corr. (dB)	Limit (dBμV)	Margin (dB)	Line
0.294	32.9	9.9	50.4	17.5	L1
0.528	28.5	9.9	46	17.5	L1
0.704	27.8	9.8	46	18.2	L1
0.879	26.1	9.8	46	19.9	L1
1.118	26.7	9.8	46	19.3	L1
23.262	36.8	9.9	50	13.3	N

Note 2) Level (QP and/or CAV) = Meter Reading (QP and/or CAV) + Corr. (LISN Insertion Loss + Cable Loss)

Margin (QP and/or CAV) = Limit – Level (QP and/or CAV)

QP = Quasi-Peak, CAV = CISPR-Average, Corr. = Correction Factor

5.2 Radiated disturbance

The following data lists the significant emission frequencies, measured levels, correction factors (for antenna and cables), orientation of table, polarization and height of antenna, the corrected reading, the limit, and the amount of margin.

Peak measurements were made over the changeable frequency range 30 MHz to 1 GHz at a measurement distance of 10 m for the following antenna and turntable arrangements:

Antenna Height [cm]	Antenna Polarisation	Resolution Bandwidth [kHz]	Video Bandwidth [kHz]	Turntable position [degrees]
100 ~ 400	Horizontal, Vertical	120	300	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using quasi-peak detector.

Peak/CISPR-Average measurements were made over the changeable frequency range 1 GHz to 40 GHz or 5th harmonics of the highest frequency in accordance with internal maximum operating frequency at a measurement distance of 3 m for the following antenna and turntable arrangements:

Antenna Height [cm]	Antenna Polarisation	Resolution Bandwidth [MHz]	Video Bandwidth [MHz]	Turntable position [degrees]
100 ~ 400	Horizontal, Vertical	1	3	0 ~ 345 (Step size: 15 degrees)

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using peak and CISPR-average detectors.

Limits for radiated disturbance of Class B ITE at a measuring distance of 3 m and 10 m

Frequency range Limits [MHz]	Field Strength		
	3 m [$\mu\text{V/m}$]	3 m [dB($\mu\text{V/m}$)]	10 m [dB($\mu\text{V/m}$)]
30 to 88	100	40.0	29.5
88 to 216	150	43.5	33.0
216 to 960	200	46.0	35.5
Above 960	500	54.0	43.5

Results checked manually; and points close to the limit line were re-measured.

5.2.1 Test instrumentation

EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-017	EMI Test Receiver	R&S	ESU8	100483	2013-06-11	12
E5I-021	EMI Test Receiver	R&S	ESU40	100376	2013-06-11	12
E5I-036	Horn Antenna	R&S	HF907	100507	2013-04-02	24
E5I-071	BiLog Antenna	Teseq	CBL6112D	35384	2013-05-23	24
E5I-072	BiLog Antenna	Teseq	CBL6112D	36009	2013-06-03	24
E5I-073	Preamplifier	Sonoma	310N	332016	2013-06-10	12
E5I-074	Preamplifier	Sonoma	310N	332017	2013-06-10	12

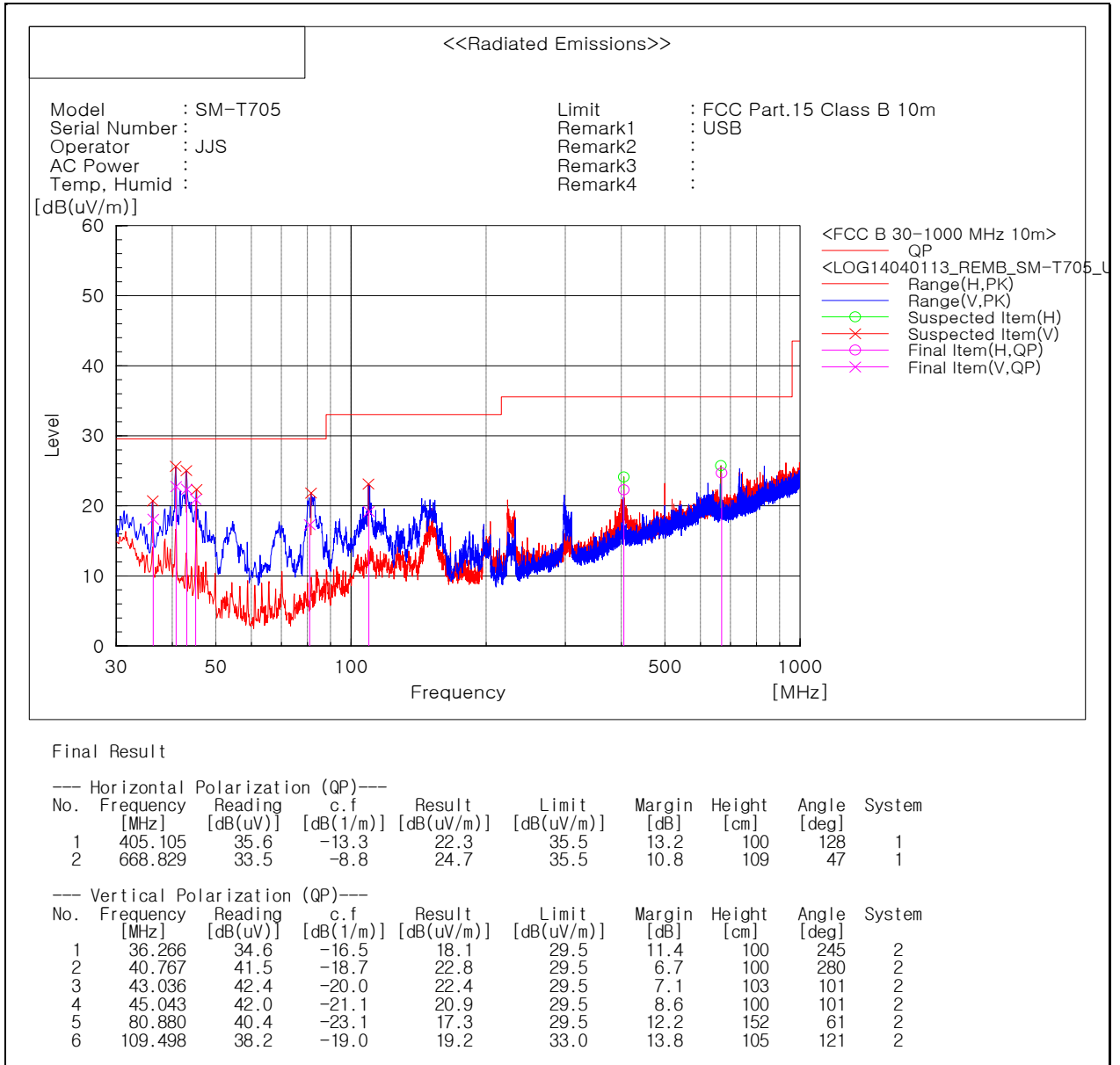
5.2.2 Temperature and humidity condition

Test date	2014-04-18	Test engineer	Jong-Sup Jeong
Climate condition	Ambient temperature	23.8 °C	Limit (15.0 to 35.0) °C
	Relative humidity	43.0 % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	101.1 kPa	Limit (86.0 to 106.0) kPa
Test place	Semi-Anechoic Chamber (SAC8)		

5.2.3 Test results

☐ Operating Mode 1

- Frequencies below 1 GHz



Note) Receiving antenna polarization : Horizontal, Vertical

Test Distance : 10 m, Antenna Height : 1 to 4 meters

Level (QP) = Reading (QP) + c.f (Antenna Factor + Cable Loss - Amp. Gain)

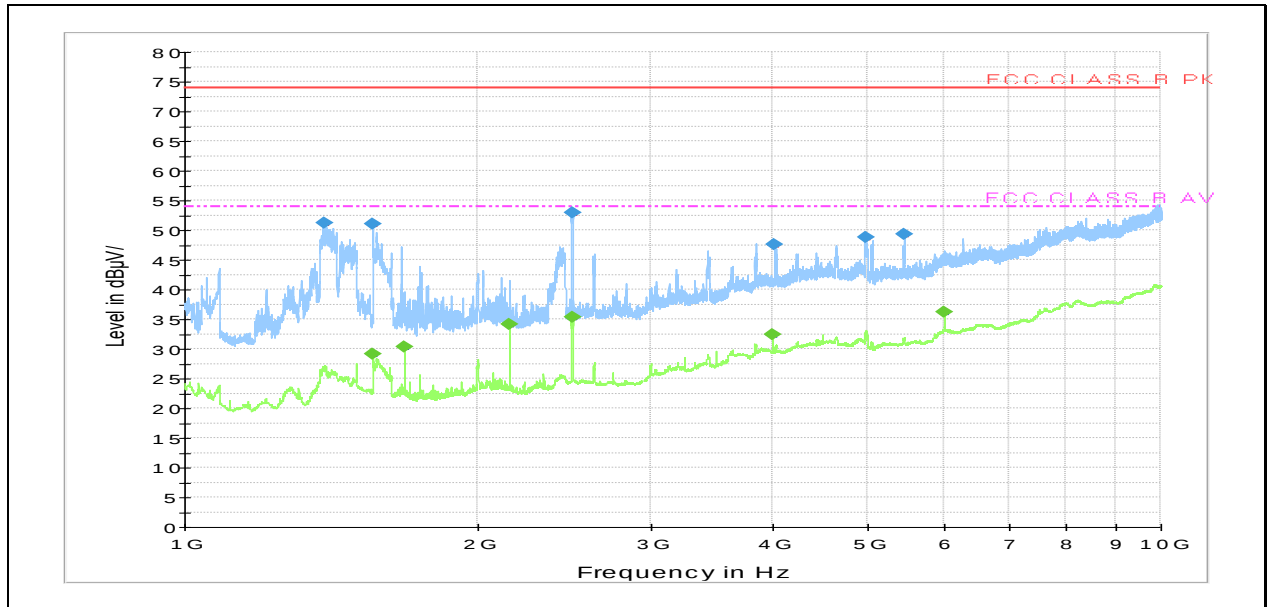
Margin (QP) = Limit - Level (QP)

QP = Quasi-Peak, c.f = Correction Factor

5.2.3 Test results

☐ Operating Mode 1

- Frequencies above 1 GHz



Final measurement results table(QP):

Frequency (MHz)	Level (dBuV/m)	Height (cm)	Polarisation	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBuV/m)
1 393.000	51.3	100	V	180	-7.5	22.7	74.0
1 560.500	51.0	100	V	180	-6.2	23.1	74.0
2 496.000	52.9	100	H	270	-0.8	21.1	74.0
4 023.000	47.5	100	H	180	6.7	26.5	74.0
4 979.000	48.8	100	H	270	9.7	25.2	74.0
5 452.000	49.4	100	H	270	10.4	24.6	74.0

Final measurement results table(CAV):

Frequency (MHz)	Level (dBuV/m)	Height (cm)	Polarisation	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBuV/m)
1 560.500	29.1	100	V	180	-6.2	24.9	54.0
1 680.000	30.4	100	H	270	-5.0	23.6	54.0
2 150.000	34.1	100	V	270	-2.5	19.9	54.0
2 494.500	35.4	100	H	270	-0.9	18.6	54.0
4 000.000	32.4	100	V	270	6.8	21.6	54.0
6 000.000	36.2	100	H	0	13.0	17.8	54.0

Note) Receiving antenna polarization : Horizontal, Vertical

Test Distance : 3 m, Antenna Height : 1 to 4 meters

Level (PK and/or CAV) = Reading (PK and/or CAV) + Corr. (Antenna Factor + Cable Loss - Amp. Gain)

Margin (PK and/or CAV) = Limit – Level (PK and/or CAV)

PK = Peak, CAV = CISPR-Average, Corr. = Correction Factor